Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/622,044	KANO ET AL.	
Examiner	Art Unit	
Richard H. Kim	2871	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East Text Seach (349/114,113)- epo,jpo,uspat,pgpub-see printout	10/2/2005	RHK